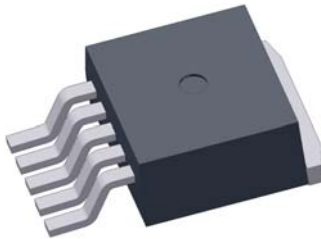


DC-to-DC Step-Down Converter

Features and Benefits

- 3.5 A output current supplied in a small, surface mount power package
- High efficiency: 83% at $V_{IN}=15\text{ V}$, $I_O=2.0\text{ A}$, $V_O=5\text{ V}$
- Requires only six external components
- Oscillation circuit built-in (frequency 300 kHz typical)
- Constant-current mode overcurrent protection circuit and overtemperature protection circuit built-in
- Output-on state at low level
- Low current consumption during output-off state

Package: TO263-5



Not to scale

Description

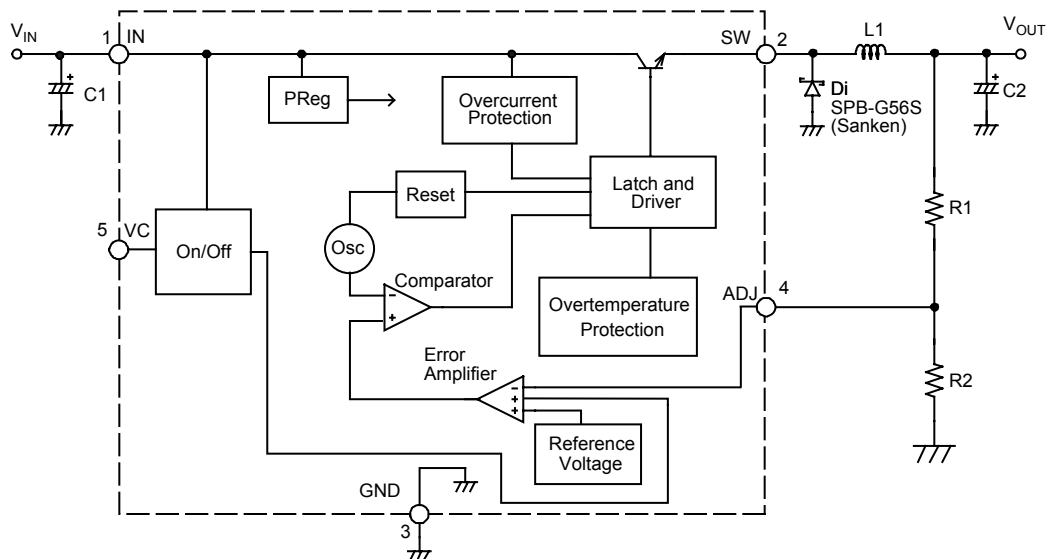
The SI-8001FDL DC voltage regulator is a DC-to-DC buck converter that attains an oscillation frequency of 300 kHz, and has an integrated miniaturized choke coil, allowing it to serve as a small, high efficiency power supply in a compact TO263 package.

The internal switching regulator function provides high efficiency switching regulation without any need for adjustment. The device requires only six external support components. Optional on/off control can be performed using a transistor. The SI-8001FDL includes overcurrent and overtemperature protection circuits.

Applications include:

- DVD recorder
- FPD TV
- Telecommunications equipment
- Office automation equipment, such as printers
- On-board local power supply
- Output voltage regulator for second stage of SMPS (switched mode power supply)

Functional Block Diagram



Selection Guide

Part Number	Output Voltage Adjustable Range (V)	Efficiency, Typ. (%)	Input Voltage, Max. (V)	Output Current, Max. (A)	Packing
SI-8001FDL-TL	0.8 to 24	83	40	3.5	800 pieces per reel

Absolute Maximum Ratings

Characteristic	Symbol	Remarks	Rating	Units
DC Input Voltage	V_{IN}		43	V
VC Pin Control Voltage	V_C		V_{IN}	V
Power Dissipation	P_D	Mounted on 40 mm × 40 mm exposed copper area on 40 mm × 40 mm glass-epoxy PCB; limited by internal overtemperature protection.	3	W
Junction Temperature	T_J	Internal overtemperature protection circuit may enable when $T_J \geq 130^\circ\text{C}$. During product operation, recommended $T_J \leq 125^\circ\text{C}$.	-40 to 150	$^\circ\text{C}$
Storage Temperature	T_{stg}		-40 to 150	$^\circ\text{C}$
Thermal Resistance (junction-to-case)	$R_{\theta JC}$	Mounted on 40 mm × 40 mm exposed copper area on 40 mm × 40 mm glass-epoxy PCB.	3	$^\circ\text{C}/\text{W}$
Thermal Resistance (junction-to-ambient air)	$R_{\theta JA}$	Mounted on 40 mm × 40 mm exposed copper area on 40 mm × 40 mm glass-epoxy PCB.	33.3	$^\circ\text{C}/\text{W}$

Recommended Operating Conditions*

Characteristic	Symbol	Remarks	Min.	Max.	Units
DC Input Voltage Range	V_{IN}	$V_{IN}(\text{min})$ is the greater of 4.5 V or $V_O + 3$ V.	See remarks	40	V
DC Output Voltage Range	V_O		0.8	24	V
DC Output Current Range	I_O	$V_{IN} \geq V_O + 3$ V; to be used within the allowable package power dissipation characteristics (refer to Power Dissipation chart).	0	3.5	A
Operating Junction Temperature Range	T_{JOP}		-30	100	$^\circ\text{C}$
Operating Temperature Range	T_{OP}	To be used within the allowable package power dissipation characteristics (refer to Power Dissipation chart).	-30	85	$^\circ\text{C}$

*Required for normal device functioning according to Electrical Characteristics table.

All performance characteristics given are typical values for circuit or system baseline design only and are at the nominal operating voltage and an ambient temperature, T_A , of 25°C , unless otherwise stated.

ELECTRICAL CHARACTERISTICS¹, valid at $T_A = 25^\circ\text{C}$, $V_O = 5\text{ V}$ (adjusted), $R1 = 4.2\text{ k}\Omega$, $R2 = 0.8\text{ k}\Omega$

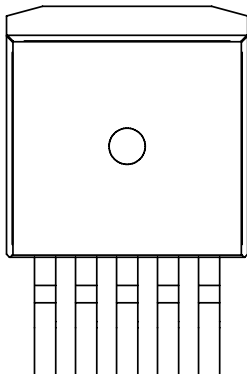
Characteristic	Symbol	Test Conditions ¹	Min.	Typ.	Max.	Units
Reference Voltage	V_{ADJ}	$V_{IN} = 15\text{ V}$, $I_O = 0.2\text{ A}$	0.784	0.800	0.816	V
Reference Voltage Temperature Coefficient	$\Delta V_{ADJ}/\Delta T$	$V_{IN} = 15\text{ V}$, $I_O = 0.2\text{ A}$, $T_C = 0\text{ to }100^\circ\text{C}$	–	± 0.1	–	mV/ $^\circ\text{C}$
Efficiency ²	η	$V_{IN} = 15\text{ V}$, $I_O = 2\text{ A}$	–	83	–	%
Operating Frequency	f_O	$V_{IN} = 15\text{ V}$, $I_O = 2\text{ A}$	270	300	330	kHz
Line Regulation	V_{Line}	$V_{IN} = 10\text{ to }30\text{ V}$, $I_O = 2\text{ A}$	–	–	80	mV
Load Regulation	V_{Load}	$V_{IN} = 15\text{ V}$, $I_O = 0.2\text{ to }3.5\text{ A}$	–	–	50	mV
Overcurrent Protection Threshold Current	I_S	$V_{IN} = 15\text{ V}$	3.6	–	–	A
VC Terminal Control Voltage (On)	$V_{C(H)}$		–	–	0.8	V
VC Terminal Control Voltage (Off)	$V_{C(L)}$		2	–	–	V
VC Terminal Control Current (On)	$I_{C(H)}$	$V_C = 2\text{ V}$	–	6	100	μA
Quiescent Current 1	I_q	$V_{IN} = 15\text{ V}$, $I_O = 0\text{ A}$	–	6	–	mA
Quiescent Current 2	$I_{q(off)}$	$V_{IN} = 15\text{ V}$, $V_C = 0\text{ V}$	–	30	200	μA

¹Using circuit shown in Typical Application Circuit diagram.

²Efficiency is calculated as: $\eta(\%) = [(V_O \times I_O) / (V_{IN} \times I_{IN})] \times 100$.

Pin-out Diagram

1 2 3 4 5



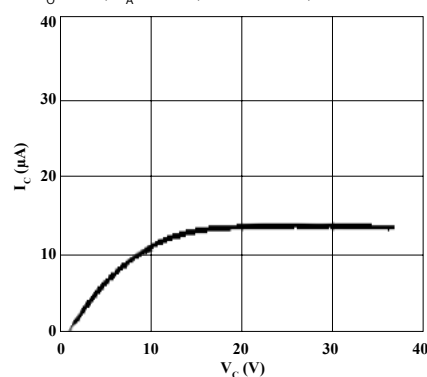
Terminal List Table

Name	Number	Function
IN	1	Supply voltage
SW	2	Regulated supply output
GND	3	Ground terminal
ADJ	4	Terminal for resistor bridge feedback
VC	5	If the VC terminal is left open, output will be in the on state. Because the input level is equivalent to LS-TTL, direct drive by LS-TTL is possible.

VC Pin Control

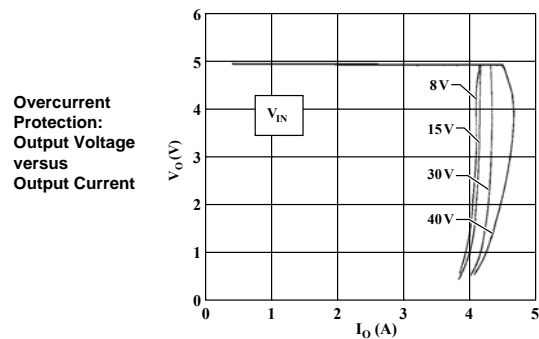
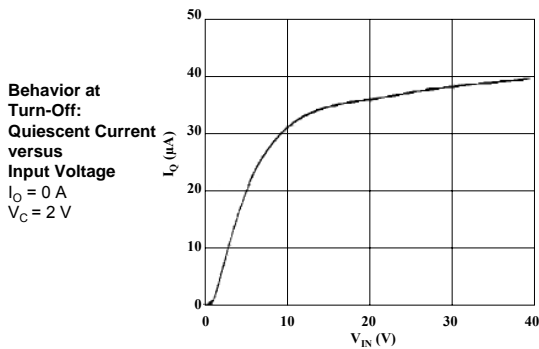
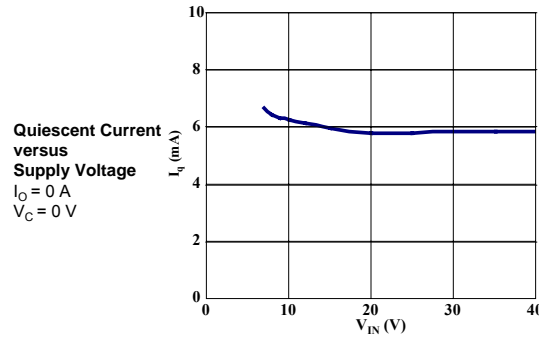
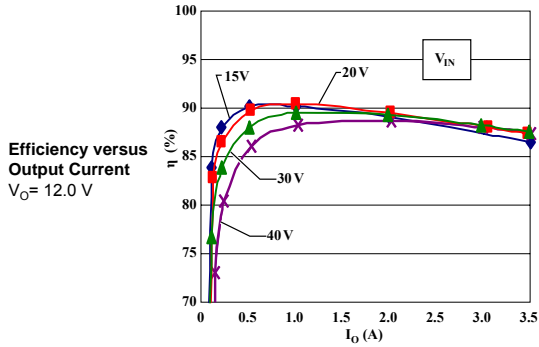
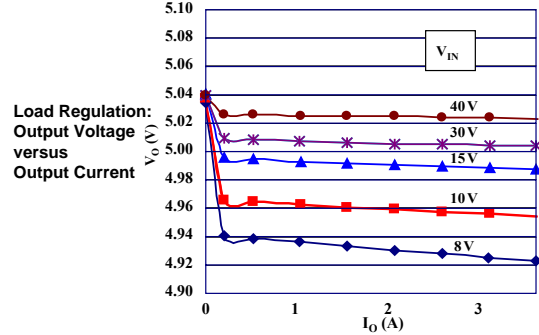
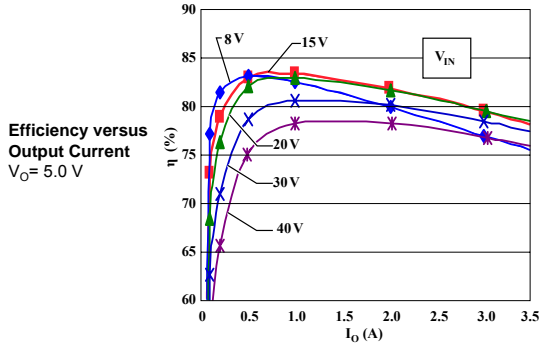
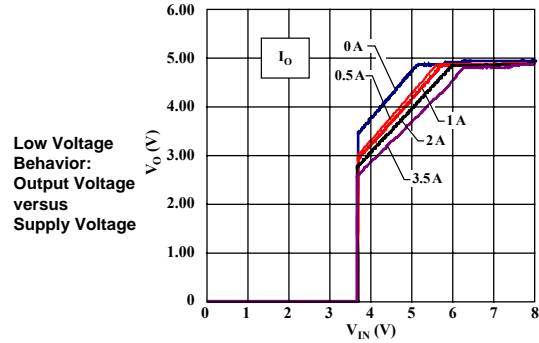
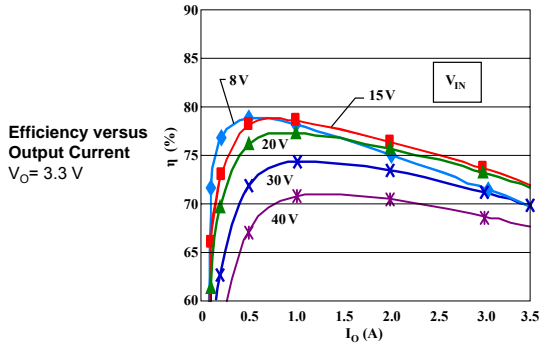
Input Current versus Input Voltage

$I_O = 0\text{ A}$, $T_A = 25^\circ\text{C}$, $R1 = 4.2\text{ k}\Omega$, $R2 = 0.8\text{ k}\Omega$



Performance Characteristics

At $T_A = 25^\circ\text{C}$, $V_O = 5\text{ V}$ Adjusted, $R_1 = 4.2\text{ k}\Omega$, $R_2 = 0.8\text{ k}\Omega$



Thermal Performance Characteristics

The application must be designed to ensure that the $T_J(\text{max})$ of the device is not exceeded during operation. To do so, it is necessary to determine values for maximum power dissipation, $P_D(\text{max})$, and ambient temperature, $T_A(\text{max})$.

The relationships of T_J , P_D , T_A , and case temperature, T_C , are as shown in the following formulas:

$$P_D = \frac{T_J - T_C}{R_{\theta JC}} \quad \text{and} \quad P_D = \frac{T_J - T_A}{R_{\theta JA}}$$

P_D can be calculated from input values:

$$P_D = V_O \cdot I_O \left(\frac{100}{\eta_x} - 1 \right) - V_F \cdot I_O \left(1 - \frac{V_O}{V_{IN}} \right)$$

where:

V_O is output voltage in V,

V_{IN} is input supply voltage in V,

I_O is output current in A,

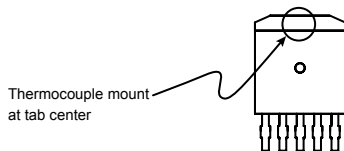
η_x is IC efficiency in percent (varies with V_{IN} and I_O ; refer to efficiency performance curves for value), and

V_F is forward voltage for the input diode, Di. In these tests, the Sanken SPB-G56S was used, at 0.4 V. For application design, obtain thermal data from the datasheet for the diode.

P_D is substantially affected by the heat conductance properties of the application, in particular any exposed copper area on the PCB where the device is mounted. The relationships of P_D , T_A , and copper area is represented in the Power Dissipation chart.

$R_{\theta JA}$ for a given copper area can be determined from the Device Thermal Resistance chart. This can be substituted into the formula above to determine the $T_J(\text{max})$ allowable in the application. Generally, more than 10% to 20% derating is required.

Because the heat dissipation capacity of the copper area depends substantially on how it is used in the actual application, thermal characteristics of the application must be confirmed by testing. T_C is determined by connecting a thermocouple to the device as shown here:



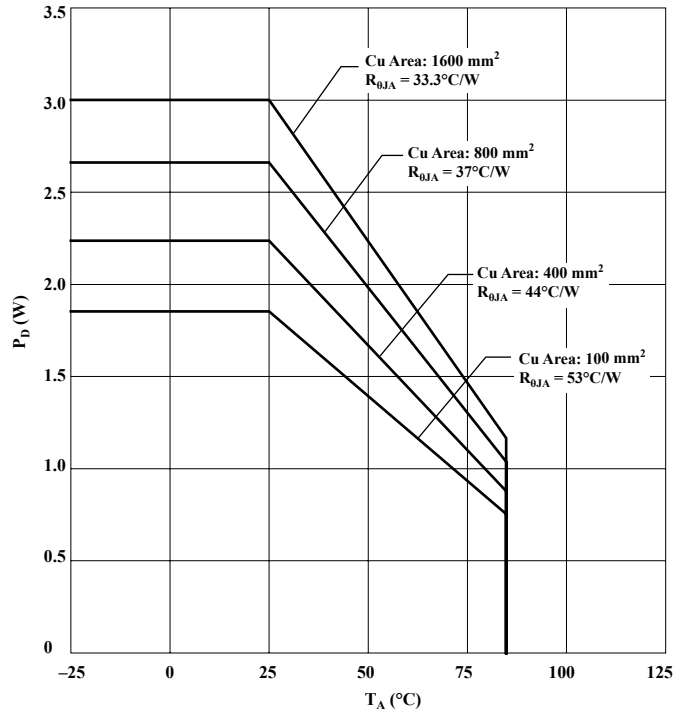
And analyzing the results using the following formula:

$$T_J = P_D \times R_{\theta JC} + T_C$$

for this device, $R_{\theta JC}$ is 3 °C/W.

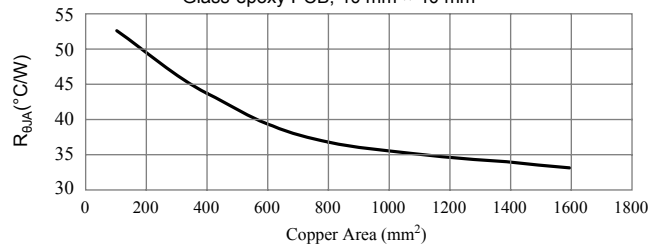
Power Dissipation versus Ambient Temperature

$T_J(\text{max}) = 125^\circ\text{C}$; Mounted on glass-epoxy PCB (40 mm × 40 mm), with varying exposed copper areas

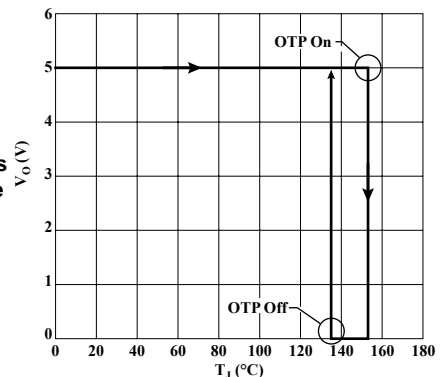


Device Thermal Resistance versus Exposed Copper Area on PCB

Glass-epoxy PCB, 40 mm × 40 mm



Overtemperature Protection: Output Voltage versus Junction Temperature
 $V_{IN} = 15 \text{ V}$, $I_O = 10 \text{ mA}$



Component Selection

Diode Di A Schottky-barrier diode must be used for Di. If other diode types are used, such as fast recovery diodes, the IC may be destroyed because of the reverse voltage applied by the recovery voltage or ON voltage.

Choke Coil L1 If the winding resistance of the choke coil is too high, the efficiency may be reduced below rating. Because the overcurrent protection start current is approximately 4.2 A, attention must be paid to the heating of the choke coil by magnetic saturation due to overload or short-circuited load.

Capacitors C1 and C2 Because for SMPS, large ripple currents flow across C1 and C2, capacitors with high frequency and low impedance must be used. If the impedance of C2 is too high,

the switching waveform may not be normal at low temperatures. Do not use either OS or tantalum types of capacitors for C2, because the extremely low ESR causes an abnormal oscillation.

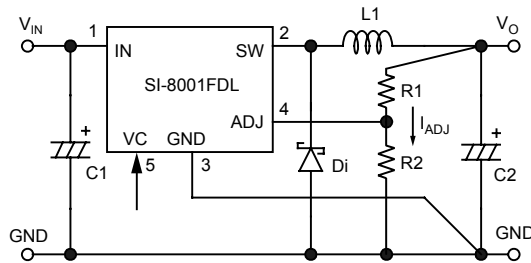
The device is stabilized, and for proper operation, C1 must be located close to the device (see layout diagram, below).

Resistor Bridge R1 and R2 R1 and R2 comprise the resistor bridge for the output voltage, V_O , and are calculated as follows:

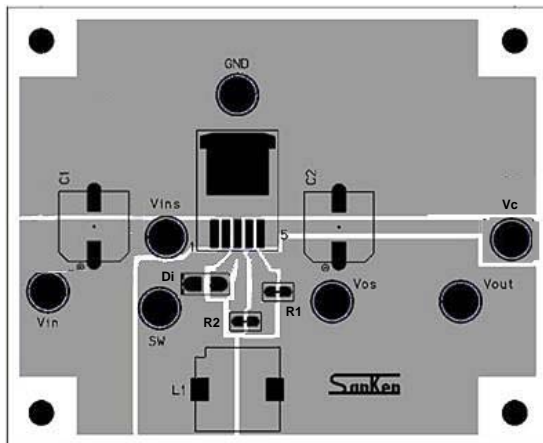
$$R1 = \frac{(V_O - V_{ADJ})}{I_{ADJ}} = \frac{(V_O - 0.8)}{1 \times 10^{-3}} (\Omega), \text{ and } R2 = \frac{V_{ADJ}}{I_{ADJ}} = \frac{0.8}{1 \times 10^{-3}} = 0.8 \text{ (k}\Omega\text{)}$$

I_{ADJ} should always be set to 1 mA. Note that R2 should always be present to ensure stable operation, even if V_O is set to 0.8 V (that is, even if there is no R1). V_O should be at least $V_{IN} + 8\%$.

Typical Application Diagram



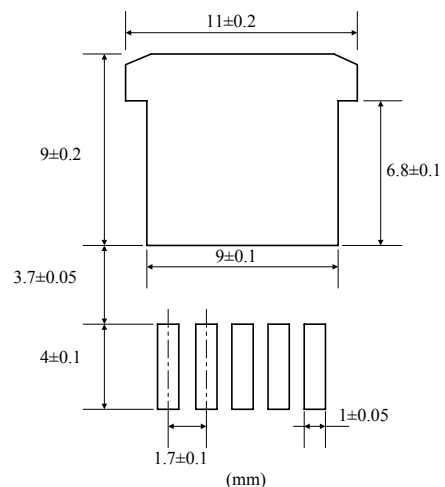
Recommended PCB Layout



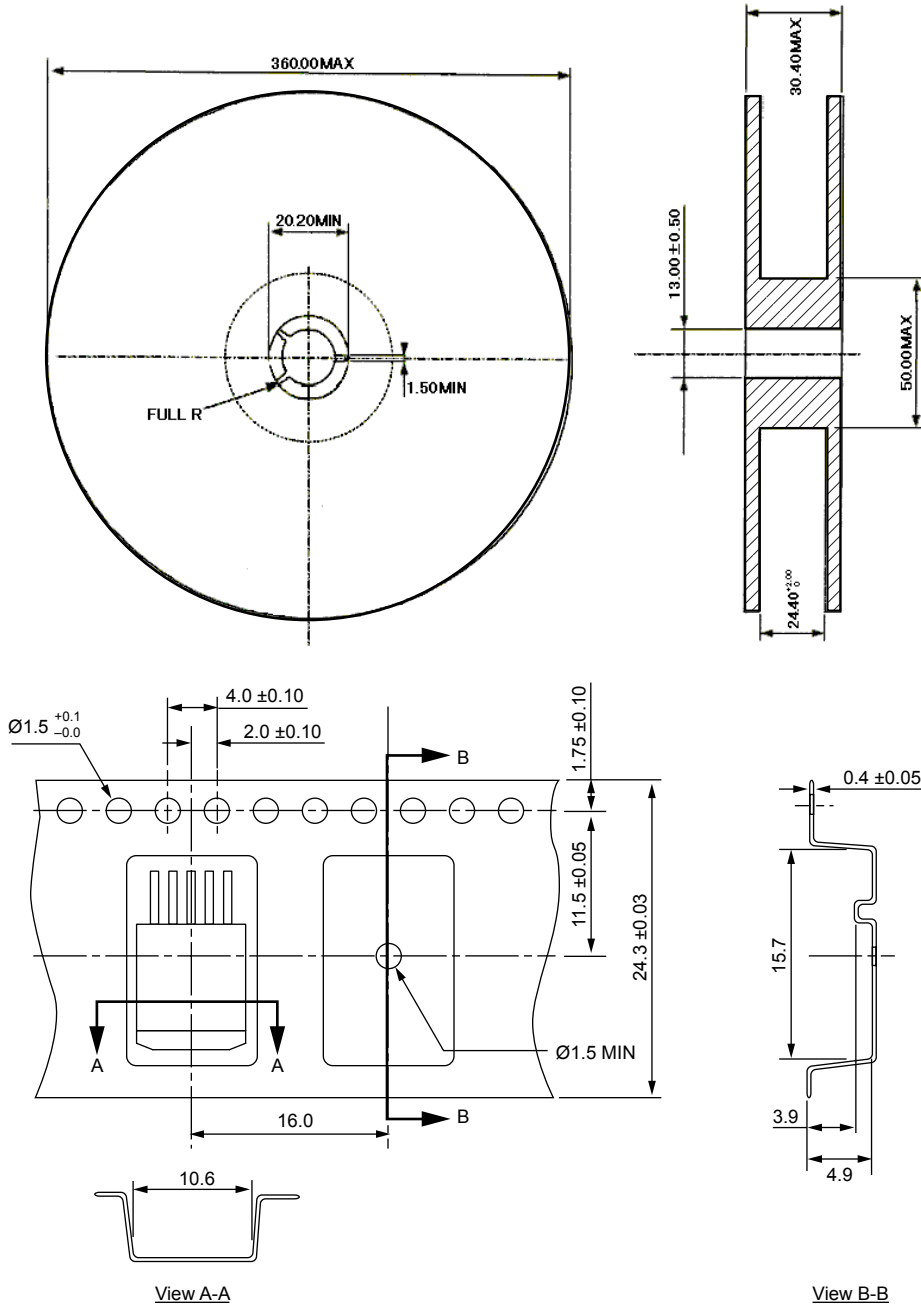
All external components should be mounted as close as possible to the SI-8001FDL. The ground of all components should be connected at one point near GND pin (pin 3).

Component	Rating
C1	470 μ F
C2	680 μ F
Di	SPB-G56S (Sanken)
L1	47 μ H

Recommended Solder Pad Layout



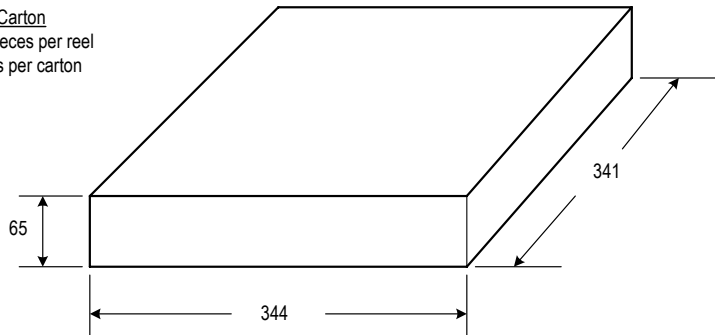
TAPE AND REEL SPECIFICATION



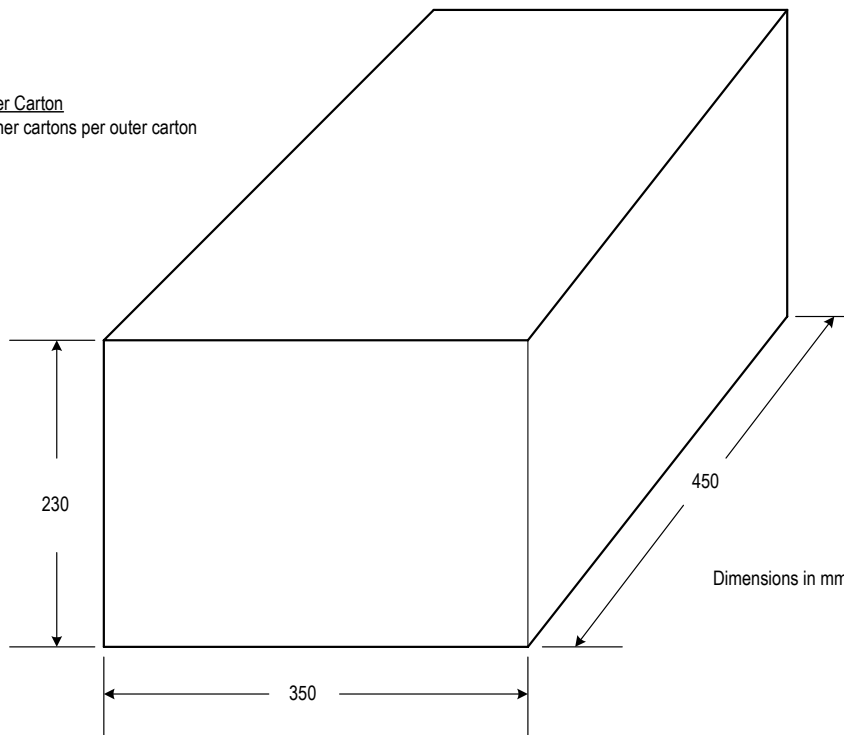
Material: conductive polyesterene
 Camber < 1 mm over 100 length of tape
 Pocket inner widths measured 0.3 mm above floor of pocket
 Pocket position relative to sprocket hole measured to true position of pocket
 10 sprocket hole pitch cumulative ± 0.2 mm
 Pocket center and pocket hole center ± 0.3 mm
 Surface resistivity < $10^7 \Omega / \text{cm}^2$

PACKING SPECIFICATION

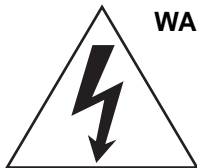
Inner Carton
800 pieces per reel
2 reels per carton



Outer Carton
3 inner cartons per outer carton



Dimensions in mm



WARNING — These devices are designed to be operated at lethal voltages and energy levels. Circuit designs that embody these components must conform with applicable safety requirements. Precautions must be taken to prevent accidental contact with power-line potentials. Do not connect grounded test equipment.

The use of an isolation transformer is recommended during circuit development and breadboarding.

Cautions for Use

- Operation of the product in parallel to increase current is not permitted.
- Although the product has an internal overtemperature protection circuit, that is intended only to protect the product from temporary excess heating due to overloads. Long-term reliability cannot be guaranteed when the product is operated under continuous overload conditions.

Because reliability can be affected adversely by improper storage environments and handling methods, please observe the following cautions.

Cautions for Storage

- Ensure that storage conditions comply with the standard temperature (5°C to 35°C) and the standard relative humidity (around 40 to 75%); avoid storage locations that experience extreme changes in temperature or humidity.
- Avoid locations where dust or harmful gases are present and avoid direct sunlight.
- Reinspect for rust on leads and solderability of products that have been stored for a long time.

Cautions for Testing and Handling

When tests are carried out during inspection testing and other standard test periods, protect the products from power surges from the testing device, shorts between adjacent products, and shorts to the heatsink.

Electrostatic Discharge

- When handling the products, operator must be grounded. Grounded wrist straps worn should have at least 1 MΩ of resistance to ground to prevent shock hazard.
- Workbenches where the products are handled should be grounded and be provided with conductive table and floor mats.
- When using measuring equipment such as a curve tracer, the equipment should be grounded.
- When soldering the products, the head of soldering irons or the

solder bath must be grounded in order to prevent leak voltages generated by them from being applied to the products.

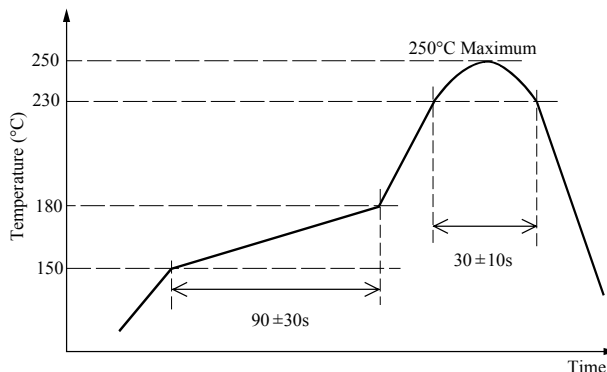
- The products should always be stored and transported in our shipping containers or conductive containers, or be wrapped in aluminum foil.

Soldering

- When manually soldering the products, please be sure to minimize the working time, within the following limits:

Soldering Iron Temperature (°C)	Time (s)
380±10	3 (once only)

- Reflow soldering can be performed a maximum of twice, using the following recommended profile:



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